



**Fast Thyristor
Type TFIS143-500-11**

Low switching losses
Low reverse recovery charge
Distributed amplified gate for high di_T/dt

Mean on-state current	I_{TAV}	500 A
Repetitive peak off-state voltage	V_{DRM}	1000 ÷ 1100 V
Repetitive peak reverse voltage	V_{RRM}	
Turn-off time	t_q	5.0; 6.3 μ s
V_{DRM}, V_{RRM}, V	1000	1100
Voltage code	10	11
$T_{j}, ^\circ C$	- 60 ÷ 125	

MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions
ON-STATE				
I_{TAV}	Mean on-state current	A	500 760	$T_c = 86^\circ C$; Double side cooled; $T_c = 55^\circ C$; Double side cooled; 180° half-sine wave; 50 Hz
I_{TRMS}	RMS on-state current	A	785	$T_c = 86^\circ C$; Double side cooled; 180° half-sine wave; 50 Hz
I_{TSM}	Surge on-state current	kA	9.0 10.3	180° half-sine wave; 50 Hz ($t_p = 10$ ms); single pulse; $V_D = V_R = 0$ V; Gate pulse: $I_G = I_{FGM}$; $V_G = 20$ V; $t_{GP} = 50 \mu$ s; $di_G/dt = 1$ A/ μ s
			10.0 11.5	180° half-sine wave; 60 Hz ($t_p = 8.3$ ms); single pulse; $V_D = V_R = 0$ V; Gate pulse: $I_G = I_{FGM}$; $V_G = 20$ V; $t_{GP} = 50 \mu$ s; $di_G/dt = 1$ A/ μ s
I^2t	Safety factor	$A^2s \cdot 10^3$	405 530	180° half-sine wave; 50 Hz ($t_p = 10$ ms); single pulse; $V_D = V_R = 0$ V; Gate pulse: $I_G = I_{FGM}$; $V_G = 20$ V; $t_{GP} = 50 \mu$ s; $di_G/dt = 1$ A/ μ s
			415 545	180° half-sine wave; 60 Hz ($t_p = 8.3$ ms); single pulse; $V_D = V_R = 0$ V; Gate pulse: $I_G = I_{FGM}$; $V_G = 20$ V; $t_{GP} = 50 \mu$ s; $di_G/dt = 1$ A/ μ s
BLOCKING				
V_{DRM}, V_{RRM}	Repetitive peak off-state and Repetitive peak reverse voltages	V	1000÷1100	$T_{j \min} < T_j < T_{j \max}$; 180° half-sine wave; 50 Hz; Gate open
V_{DSM}, V_{RSM}	Non-repetitive peak off-state and Non-repetitive peak reverse voltages	V	1100÷1200	$T_{j \min} < T_j < T_{j \max}$; 180° half-sine wave; 50 Hz; single pulse; Gate open
V_D, V_R	Direct off-state and Direct reverse voltages	V	0.75· V_{DRM} 0.75· V_{RRM}	$T_j = T_{j \max}$; Gate open

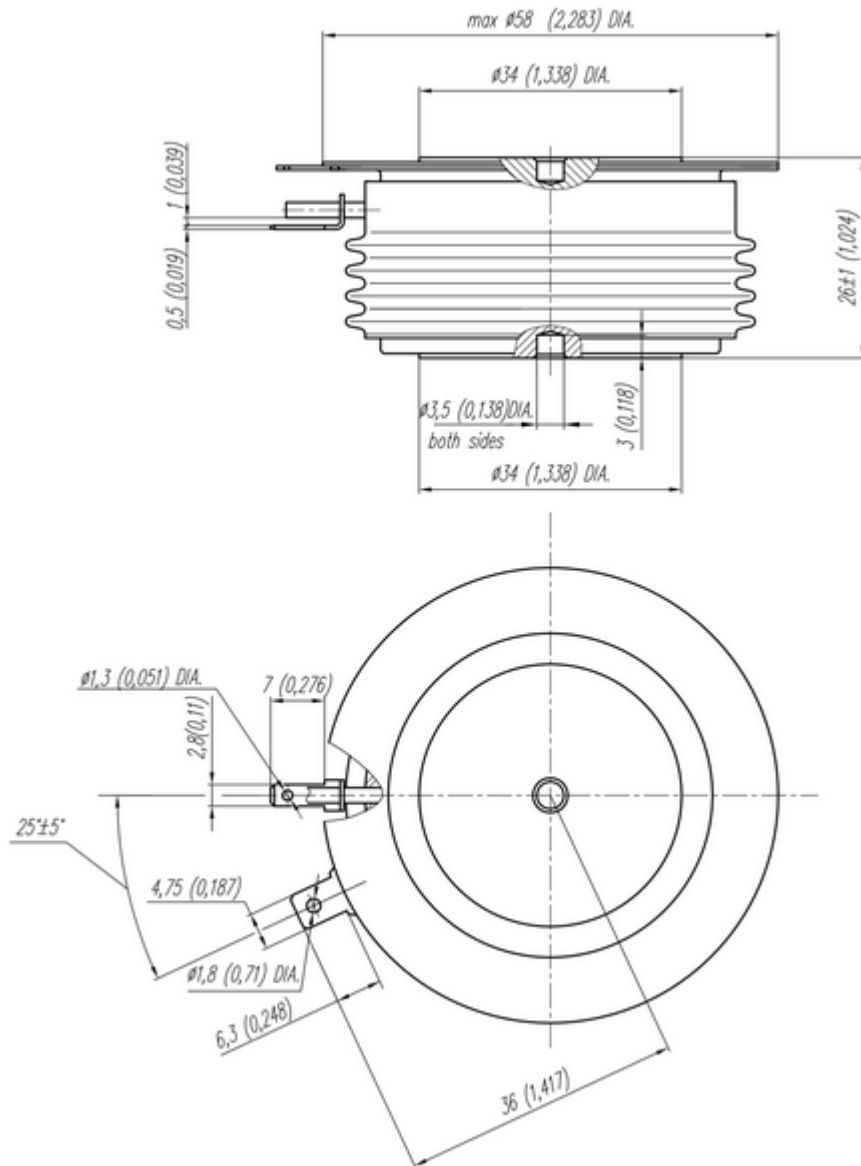
TRIGGERING					
I_{FGM}	Peak forward gate current	A	8	$T_j = T_{j\ max}$	
V_{RGM}	Peak reverse gate voltage	V	5		
P_G	Gate power dissipation	W	8	$T_j = T_{j\ max}$ for DC gate current	
SWITCHING					
$(di_T/dt)_{crit}$	Critical rate of rise of on-state current non-repetitive (f=1 Hz)	A/ μ s	2500	$T_j = T_{j\ max}; V_D = 0.67 \cdot V_{DRM}; I_{TM} = 2 I_{TAV};$ Gate pulse: $I_G = I_{FGM}; V_G = 20\ V;$ $t_{GP} = 50\ \mu s; di_G/dt = 1\ A/\mu s$	
THERMAL					
T_{stg}	Storage temperature	$^{\circ}C$	- 60 ÷ 125		
T_j	Operating junction temperature	$^{\circ}C$	- 60 ÷ 125		
MECHANICAL					
F	Mounting force	kN	14.0 ÷ 16.0		
a	Acceleration	m/s^2	50 100	Device unclamped Device clamped	

CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions	
ON-STATE					
V_{TM}	Peak on-state voltage, max	V	2.40	$T_j = 25\ ^{\circ}C; I_{TM} = 1570\ A$	
$V_{T(TO)}$	On-state threshold voltage, max	V	1.40	$T_j = T_{j\ max};$ $0.5 \pi I_{TAV} < I_T < 1.5 \pi I_{TAV}$	
r_T	On-state slope resistance, max	$m\Omega$	0.80		
I_H	Holding current, max	mA	500	$T_j = 25\ ^{\circ}C;$ $V_D = 12\ V;$ Gate open	
BLOCKING					
I_{DRM}, I_{RRM}	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	100	$T_j = T_{j\ max};$ $V_D = V_{DRM}; V_R = V_{RRM}$	
$(dv_D/dt)_{crit}$	Critical rate of rise of off-state voltage ¹⁾ , min	V/ μ s	1000	$T_j = T_{j\ max};$ $V_D = 0.67 \cdot V_{DRM};$ Gate open	
TRIGGERING					
V_{GT}	Gate trigger direct voltage, max	V	4.00 2.50 2.00	$T_j = T_{j\ min}$ $T_j = 25\ ^{\circ}C$ $T_j = T_{j\ max}$	$V_D = 12\ V; I_D = 3\ A;$ Direct gate current
I_{GT}	Gate trigger direct current, max	mA	500 300 200	$T_j = T_{j\ min}$ $T_j = 25\ ^{\circ}C$ $T_j = T_{j\ max}$	
V_{GD}	Gate non-trigger direct voltage, min	V	0.25	$T_j = T_{j\ max}; V_D = 0.67 \cdot V_{DRM};$	
I_{GD}	Gate non-trigger direct current, min	mA	10.00	Direct gate current	
SWITCHING					
t_{gd}	Delay time	μ s	2.0	$T_j = 25\ ^{\circ}C; V_D = 0.4 \cdot V_{DRM}; I_{TM} = I_{TAV};$ Gate pulse: $I_G = I_{FGM}; V_G = 20\ V;$ $t_{GP} = 50\ \mu s; di_G/dt = 1\ A/\mu s$	
t_q	Turn-off time ²⁾ , max	μ s	5.0; 6.3	$dv_D/dt = 50\ V/\mu s;$ $T_j = T_{j\ max};$ $I_{TM} = I_{TAV};$ $di_R/dt = -10\ A/\mu s;$	
			6.3; 8.0	$dv_D/dt = 200\ V/\mu s;$ $V_R = 100V;$ $V_D = 0.67 \cdot V_{DRM}$	
Q_{rr}	Total recovered charge, max	μ C	80	$T_j = T_{j\ max}; I_{TM} = 500\ A;$	
t_{rr}	Reverse recovery time, typ	μ s	2.0	$di_R/dt = -50\ A/\mu s;$	
I_{rrM}	Peak reverse recovery current, max	A	80	$V_R = 100\ V$	

THERMAL					
R_{thjc}	Thermal resistance, junction to case, max	°C/W	0.0320	Direct current	Double side cooled
R_{thjc-A}			0.0704		Anode side cooled
R_{thjc-K}			0.0576		Cathode side cooled
R_{thck}	Thermal resistance, case to heatsink, max	°C/W	0.0060	Direct current	
MECHANICAL					
w	Weight, typ	g	280		
D_s	Surface creepage distance	mm (inch)	27.60 (1.087)		
D_a	Air strike distance	mm (inch)	16.00 (0.630)		

NOTES		PART NUMBERING GUIDE																										
¹⁾ Critical rate of rise of off-state voltage <table border="1"> <tr> <td>Symbol of group</td> <td colspan="2">A2</td> </tr> <tr> <td>$(dv_D/dt)_{crit}$, V/μs</td> <td colspan="2">1000</td> </tr> </table>		Symbol of group	A2		$(dv_D/dt)_{crit}$, V/ μ s	1000		<table border="1"> <tr> <td>TFIS</td> <td>143</td> <td>500</td> <td>11</td> <td>A2</td> <td>E4</td> <td>N</td> </tr> <tr> <td>1</td> <td>2</td> <td>3</td> <td>4</td> <td>5</td> <td>6</td> <td>7</td> </tr> </table>							TFIS	143	500	11	A2	E4	N	1	2	3	4	5	6	7
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²⁾ Turn-off time ($dv_D/dt=50$ V/ μ s) <table border="1"> <tr> <td>Symbol of group</td> <td>E4</td> <td>C4</td> </tr> <tr> <td>t_{qr}, μs</td> <td>5.0</td> <td>6.3</td> </tr> </table>		Symbol of group	E4	C4	t_{qr} , μ s	5.0	6.3	<ol style="list-style-type: none"> TFI — Fast Thyristor TFIS — Fast Thyristor with Distributed Amplified Gate Design version Mean on-state current, A Voltage code Critical rate of rise of off-state voltage Group of turn-off time ($dv_D/dt=50$ V/μs) Ambient conditions: N – normal; T – tropical 																				
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t_{qr} , μ s	5.0	6.3																										



All dimensions in millimeters (inches)

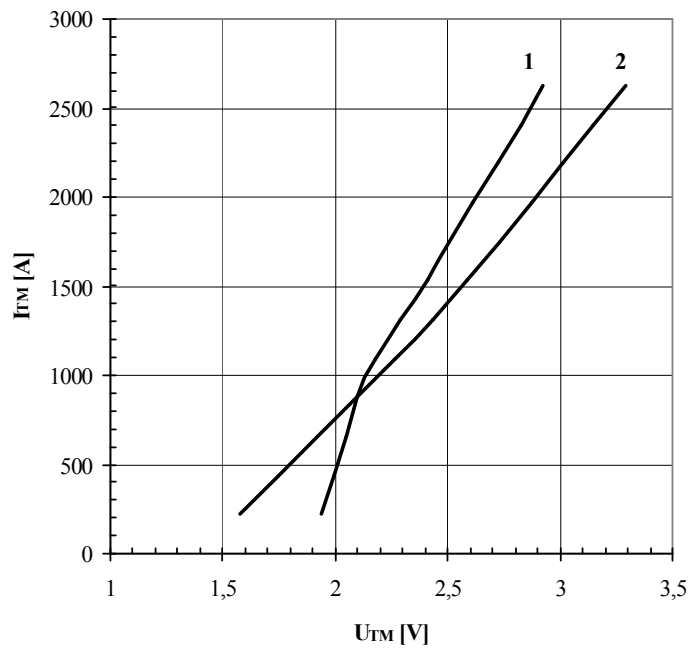
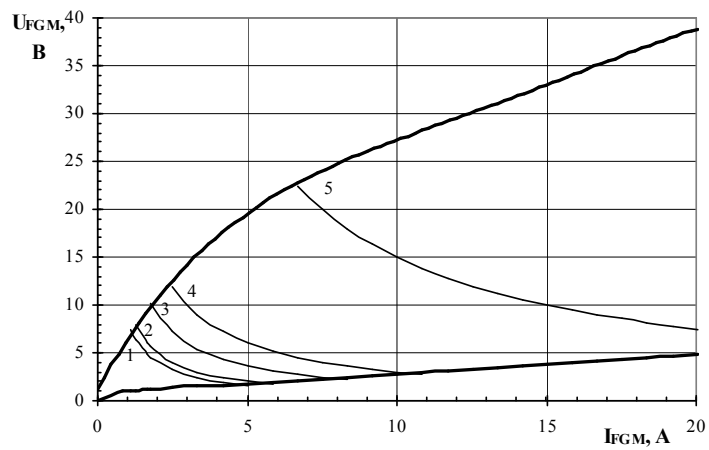


Fig. 1 On-state characteristics of Limit device
 1 – $T_j = 25\text{ °C}$
 2 – $T_j = 125\text{ °C}$



Maximum peak gate power loss

Position	On-Off time ratio	Gate pulse length, ms	Gate Pulse Power, W
1	1	DC	8
2	2	10	10
3	20	1	18
4	40	0.5	30
5	200	0.1	150

Fig. 2 Gate characteristics

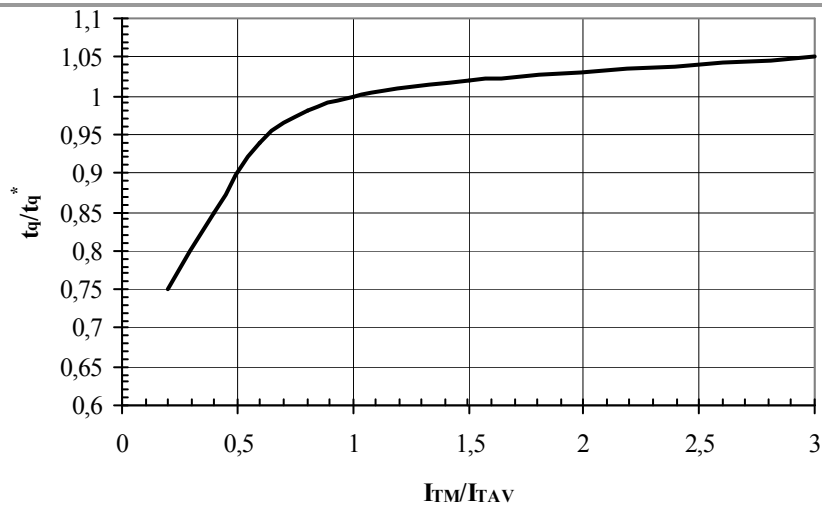


Fig. 3 Turn-off time t_q vs. On-state peak current I_{TM}

Conditions: $T_j=T_{j\ max}$; $di_R/dt=10\ A/\mu s$; $V_R=100\ V$; $dv_D/dt=50\ V/\mu s$; $V_D=0.67\cdot V_{DRM}$

Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\ V/\mu s$)

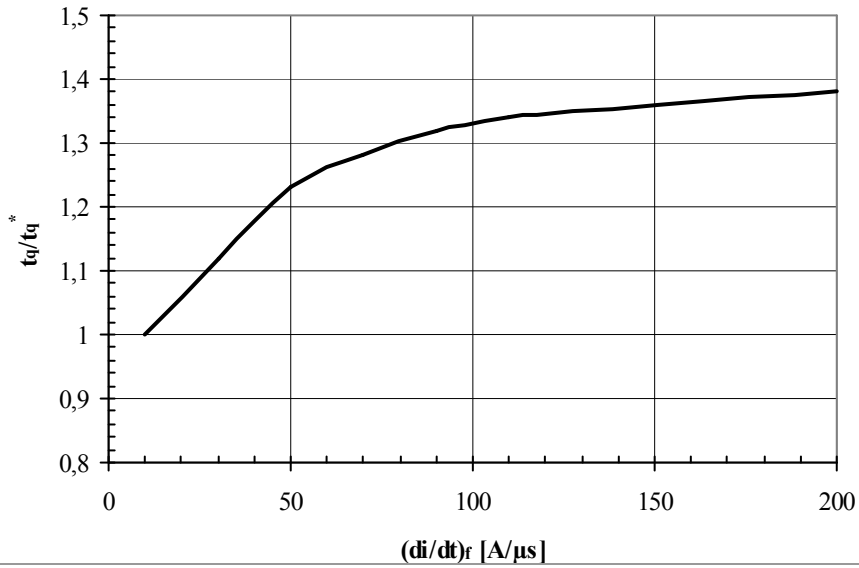


Fig. 4 Turn-off time t_q vs. Rate of fall of on-state current di_R/dt

Conditions: $T_j=T_{j\ max}$; $I_{TM}=I_{TAV}$; $V_R=100\ V$; $dv_D/dt=50\ V/\mu s$; $V_D=0.67\cdot V_{DRM}$

Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\ V/\mu s$)

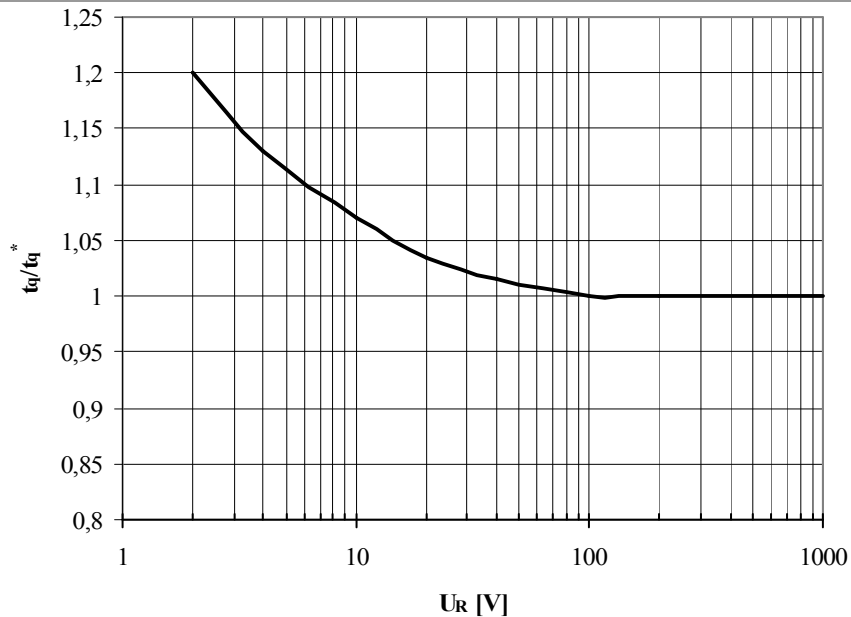


Fig. 5 Turn-off time t_q vs. Reverse voltage V_R

Conditions: $T_j=T_{j\ max}$; $I_{TM}=I_{TAV}$; $di_R/dt=10\ A/\mu s$; $dv_D/dt=50\ V/\mu s$; $V_D=0.67\cdot V_{DRM}$

Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\ V/\mu s$)

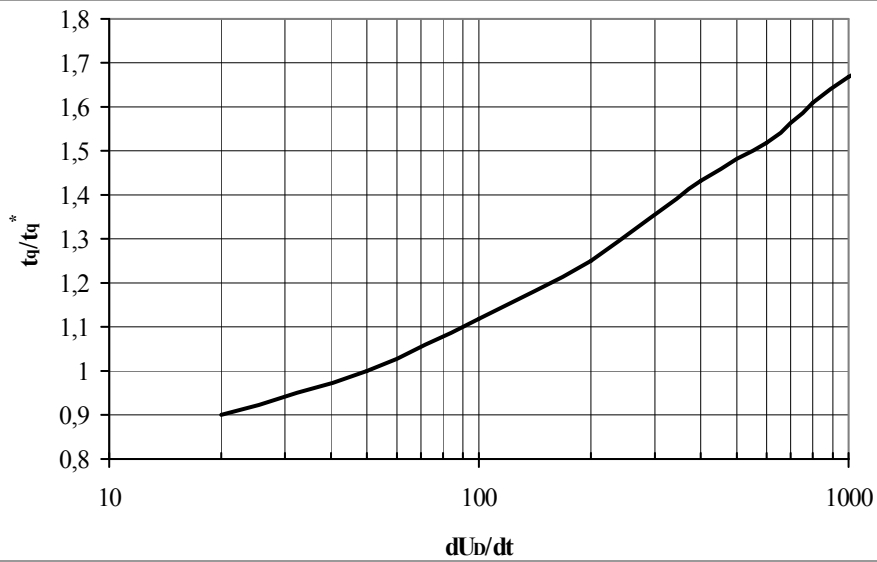


Fig. 6 Turn-off time t_q vs. Rate of rise of commutating voltage dv_D/dt

Conditions: $T_j=T_{j\max}$; $I_{TM}=I_{TAV}$; $di_R/dt=10\text{ A}/\mu\text{s}$; $V_R=100\text{ V}$; $V_D=0.67\cdot V_{DRM}$

Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\text{ V}/\mu\text{s}$)

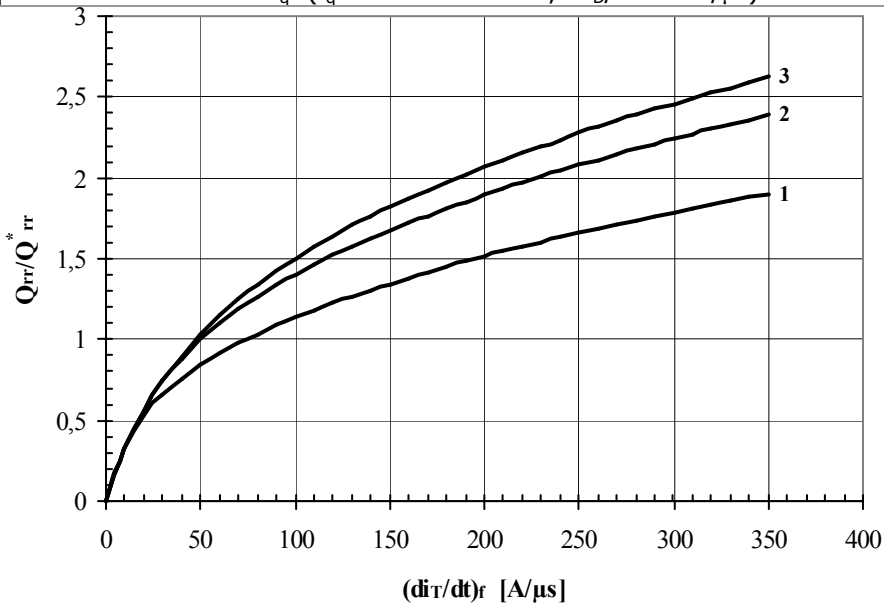


Fig. 7 Reverse recovery charge Q_{rr} vs. Rate of fall of on-state current di_R/dt

1 – $I_{TM} = 0.5 \cdot I_{TAV}$

2 – $I_{TM} = I_{TAV}$

3 – $I_{TM} = 1.5 \cdot I_{TAV}$

Conditions: $T_j=T_{j\max}$; $V_R=100\text{ V}$

Typical changes of Q_{rr} are normalized to the Q_{rr}^* (Q_{rr}^* – see data sheet)

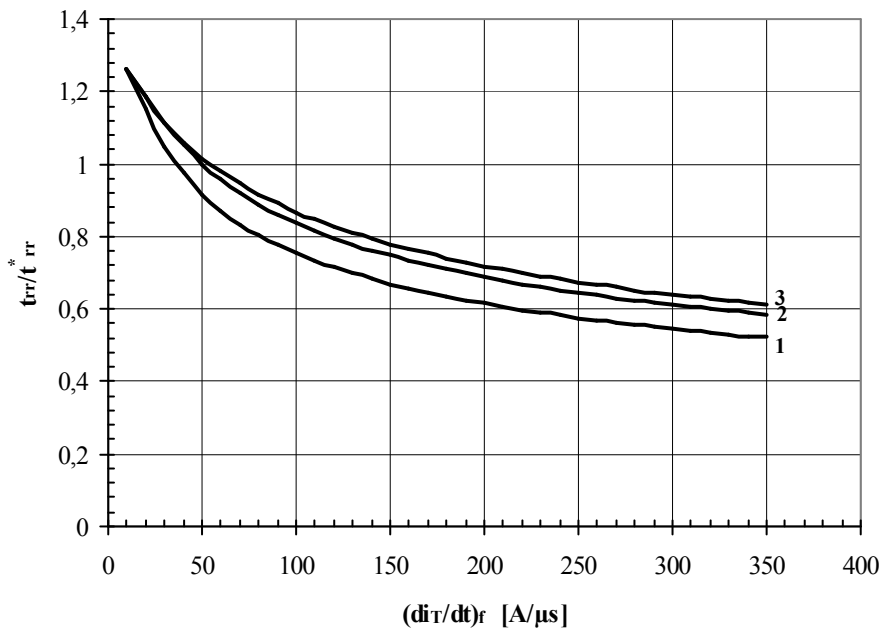


Fig. 8 Reverse recovery time t_{rr} vs. Rate of fall of on-state current di_R/dt

1 - $I_{TM} = 0.5 \cdot I_{TAV}$

2 - $I_{TM} = I_{TAV}$

3 - $I_{TM} = 1.5 \cdot I_{TAV}$

Conditions: $T_j = T_{j\ max}$; $V_R = 100\ V$

Typical changes of t_{rr} are normalized to the t_{rr}^* (t_{rr}^* – see data sheet)

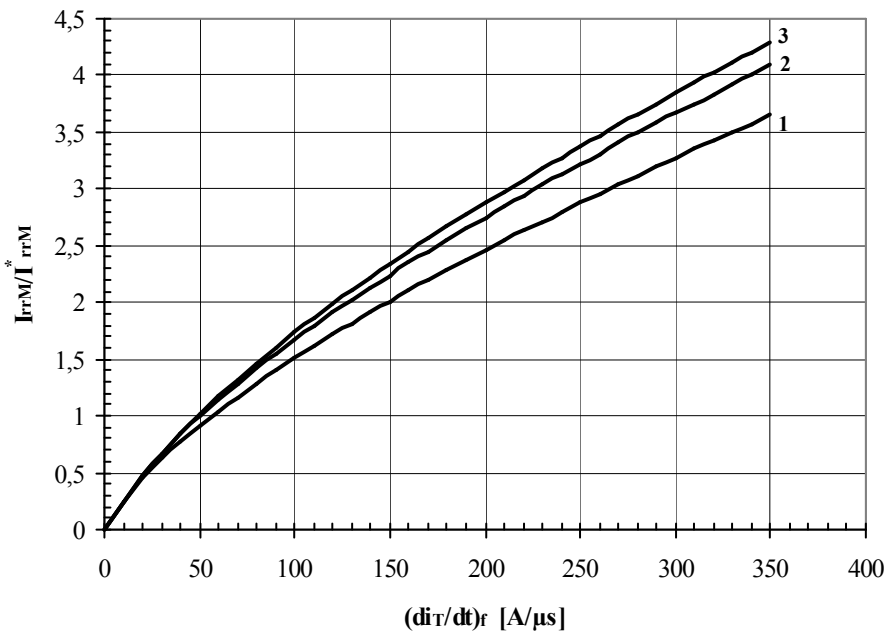


Fig. 9 Peak reverse recovery current I_{rrM} vs. Rate of fall of on-state current di_R/dt

1 - $I_{TM} = 0.5 \cdot I_{TAV}$

2 - $I_{TM} = I_{TAV}$

3 - $I_{TM} = 1.5 \cdot I_{TAV}$

Conditions: $T_j = T_{j\ max}$; $V_R = 100\ V$

Typical changes of I_{rrM} are normalized to the I_{rrM}^* (I_{rrM}^* – see data sheet)

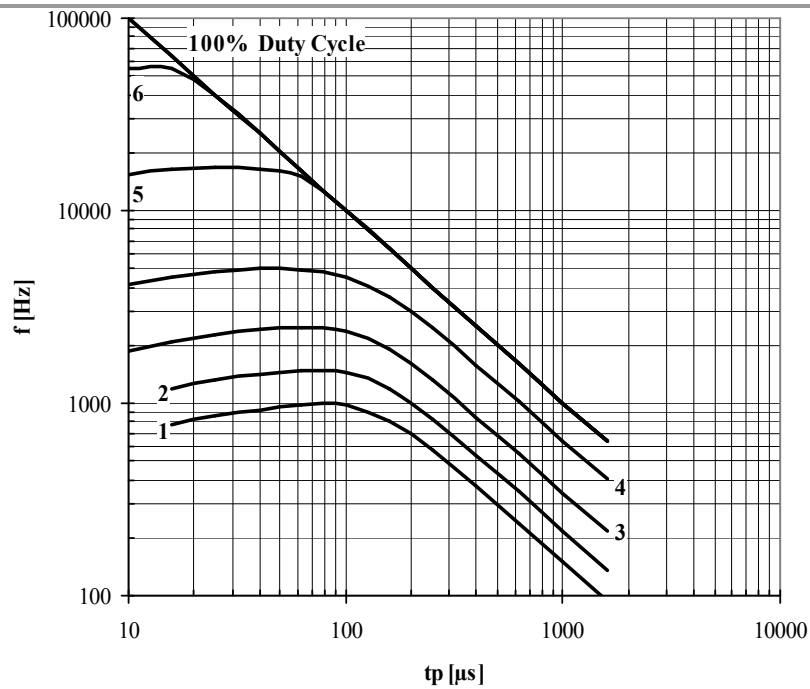


Fig. 10 Sine wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A

Conditions: $V_R \leq 3$ V; $T_C = 55$ °C

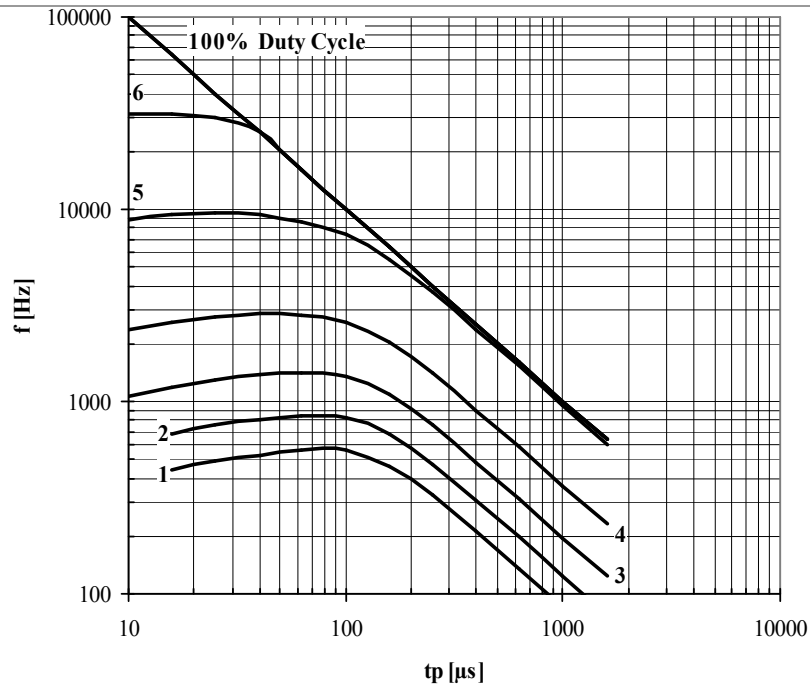


Fig. 11 Sine wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 85$ °C

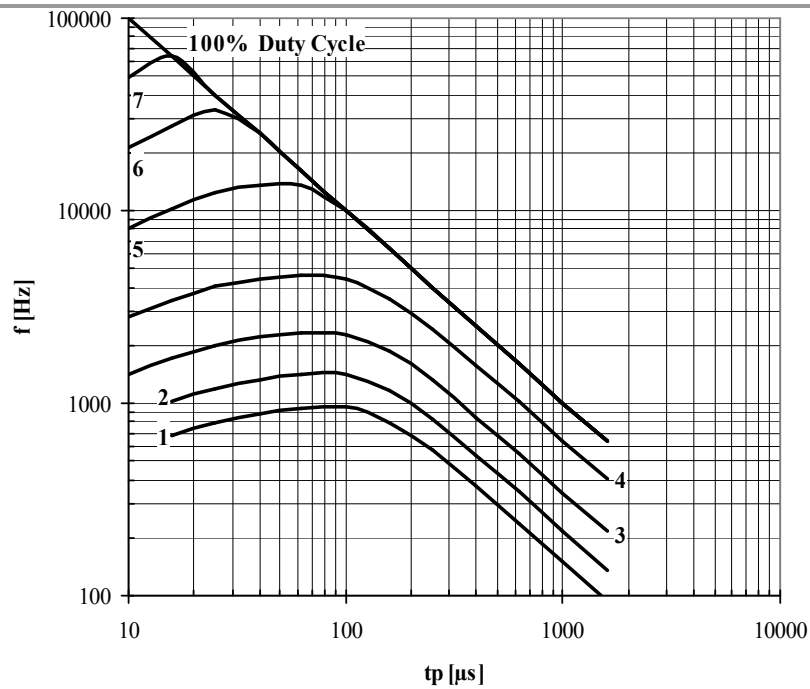


Fig. 12 Sine wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 55$ °C

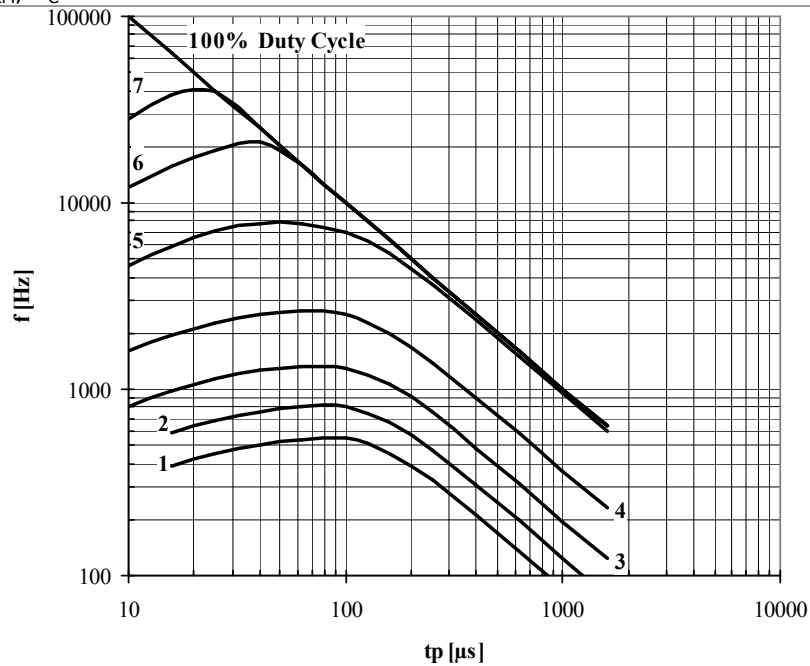


Fig. 13 Sine wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 85$ °C

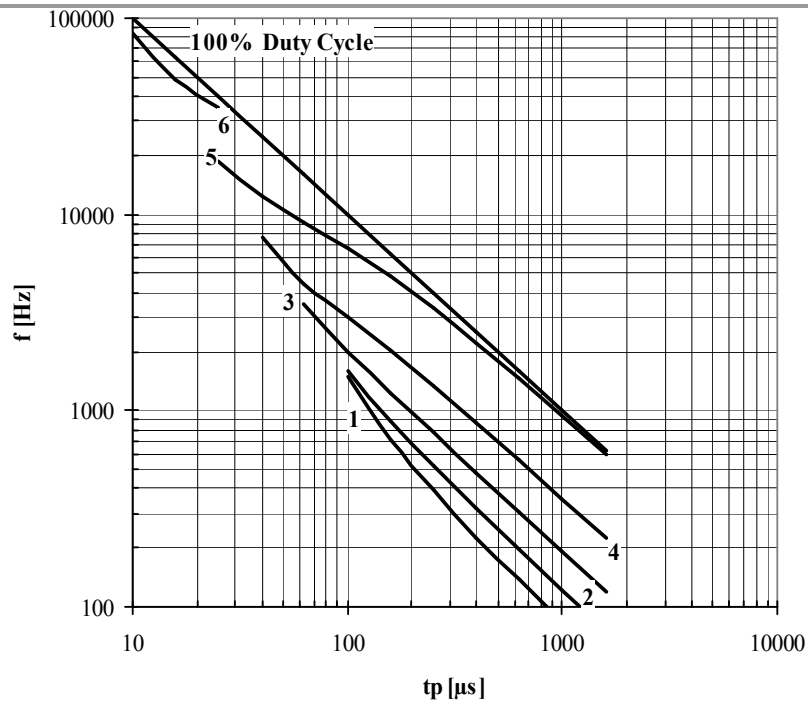


Fig. 14 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A

Conditions: $V_R \leq 3$ V; $T_C = 55$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

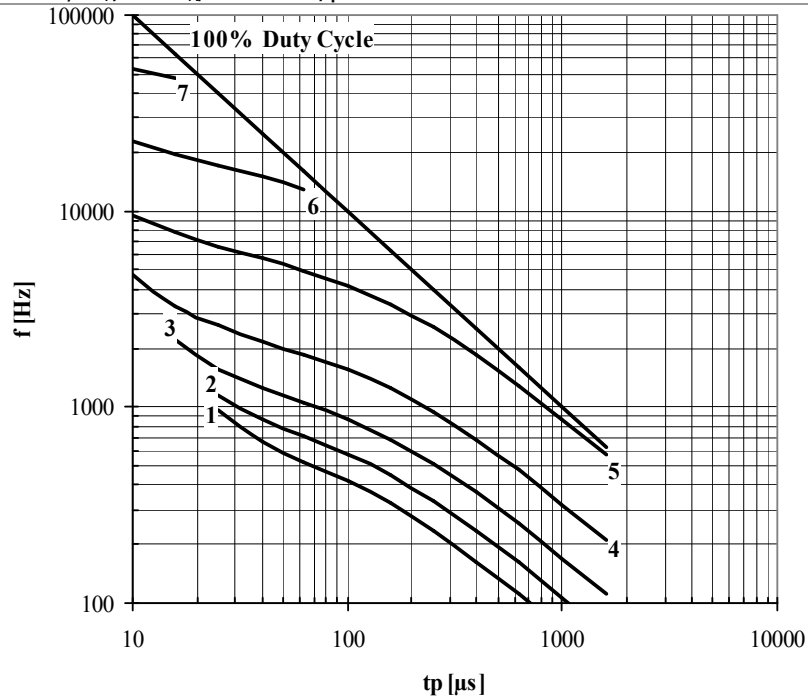


Fig. 15 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 55$ °C; $di_F/dt = di_R/dt = 500$ A/ μ s

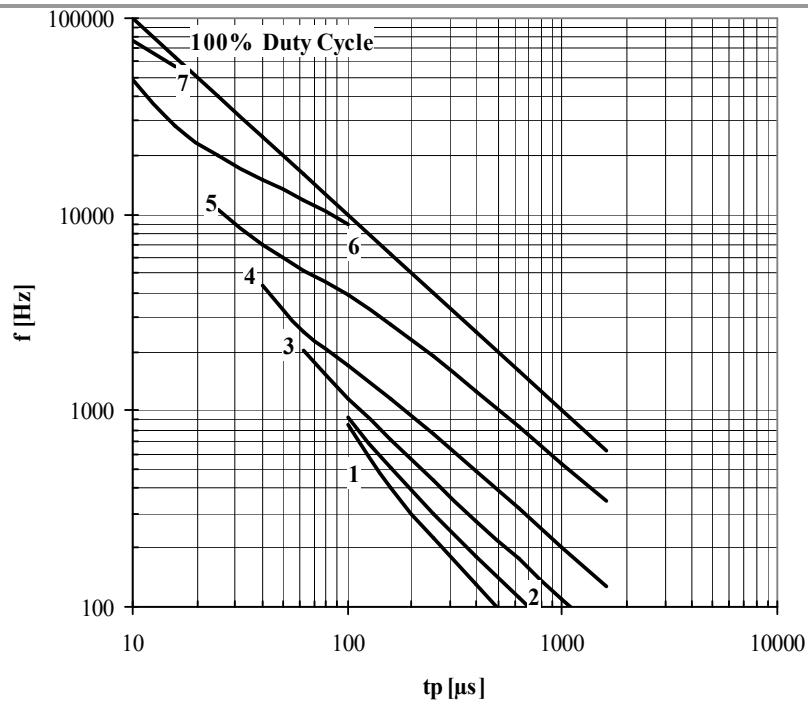


Fig. 16 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 85$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

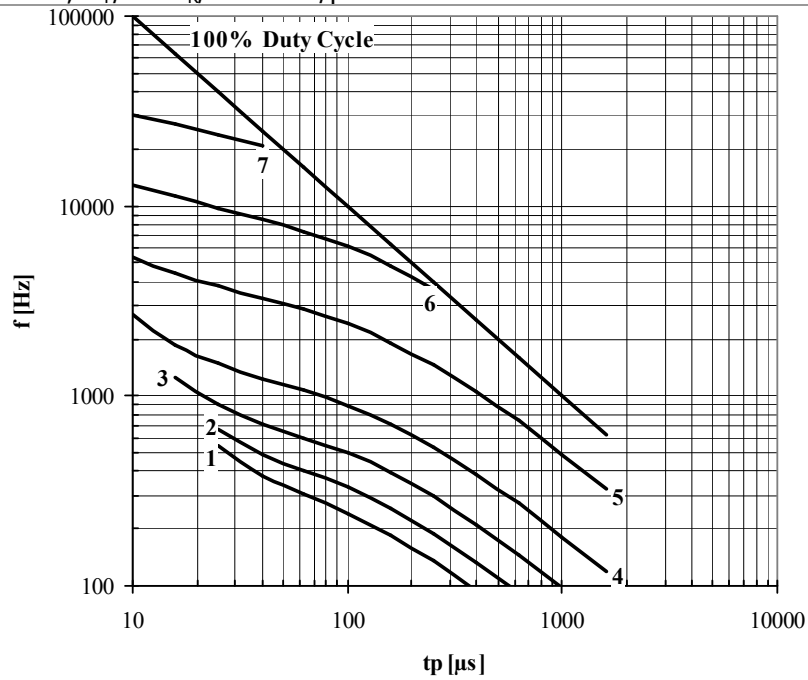


Fig. 17 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 85$ °C; $di_F/dt = di_R/dt = 500$ A/ μ s

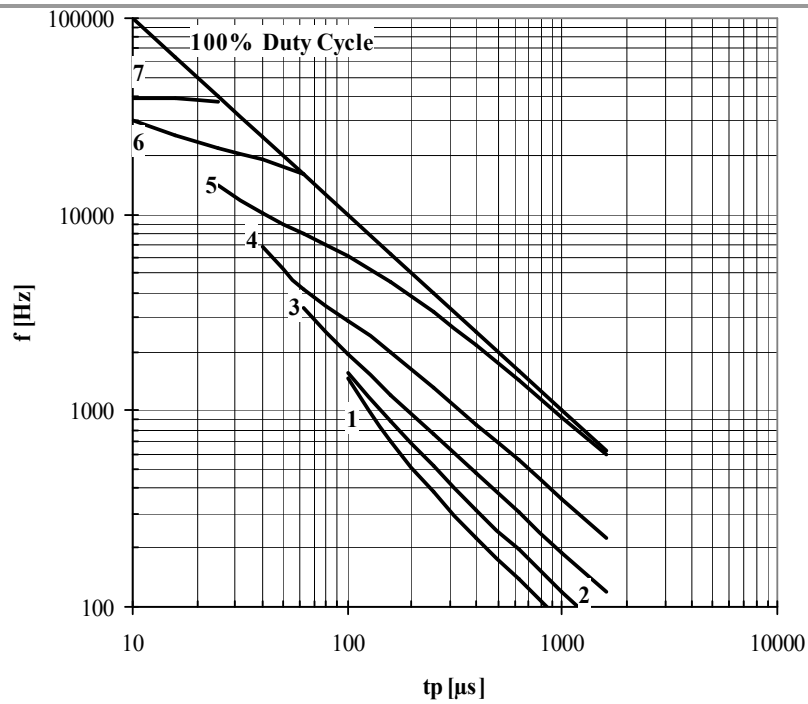


Fig. 18 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 55$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

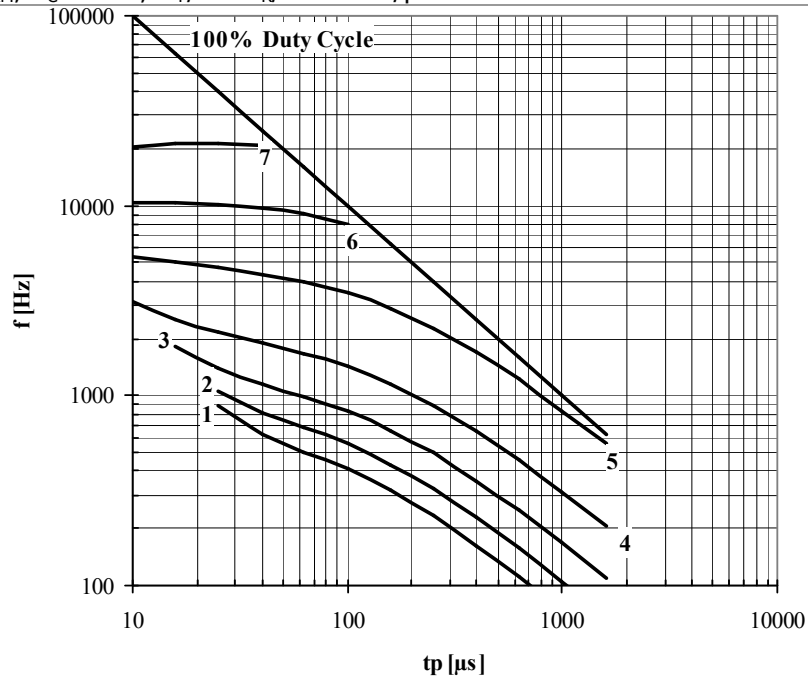


Fig. 19 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 55$ °C; $di_F/dt = di_R/dt = 500$ A/ μ s

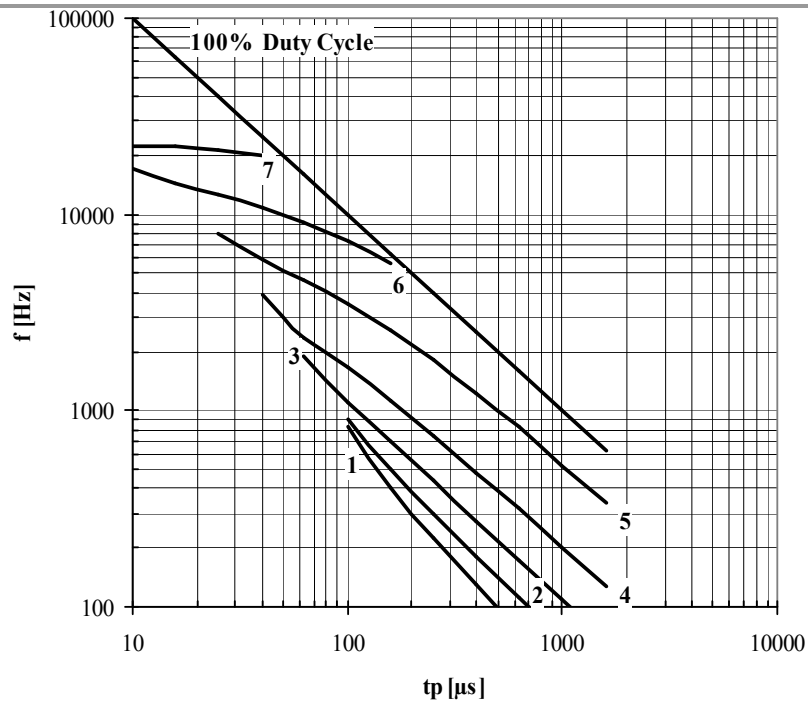


Fig. 20 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 85$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

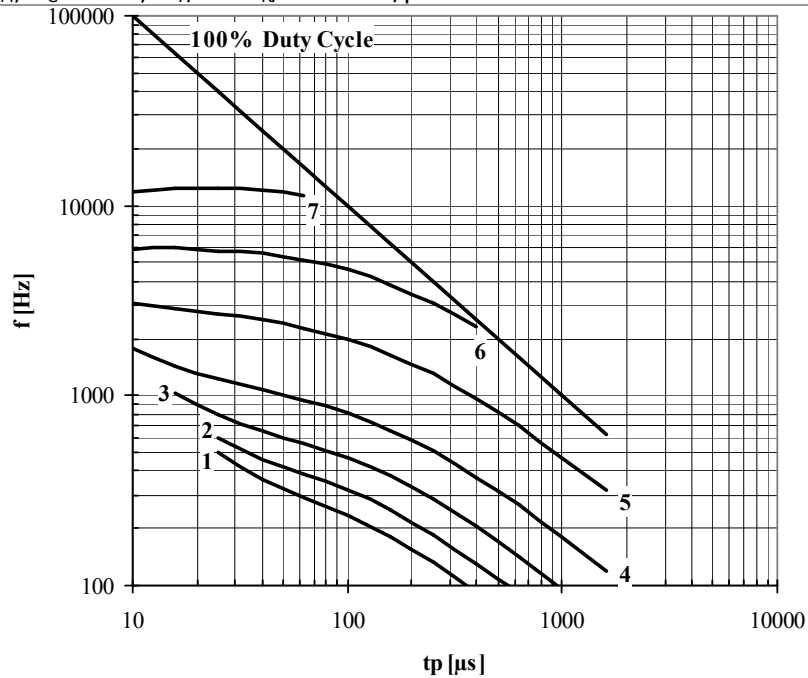


Fig. 21 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 85$ °C; $di_F/dt = di_R/dt = 500$ A/ μ s

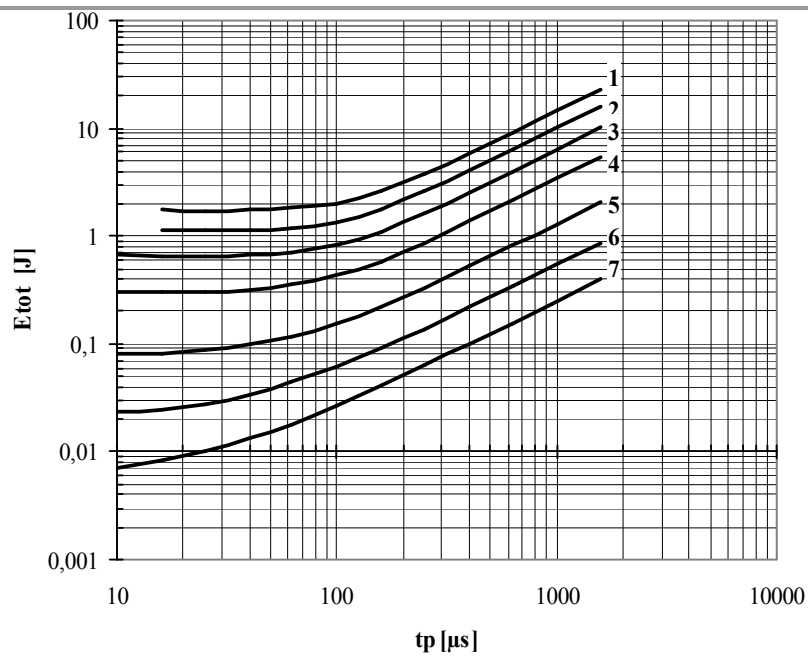


Fig. 22 Sine wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V

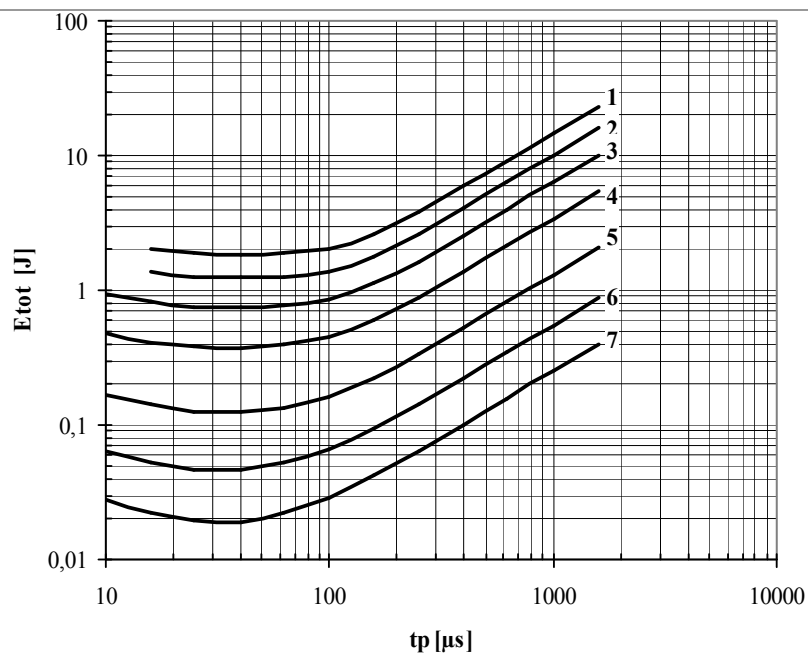


Fig. 23 Sine wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$

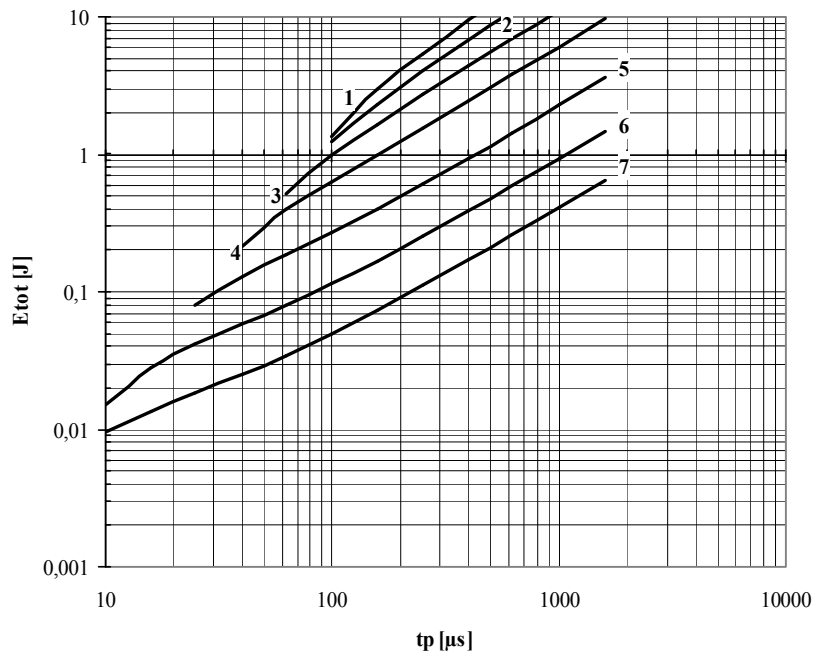


Fig. 24 Square wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $di_F/dt = di_R/dt = 100$ A/ μ s

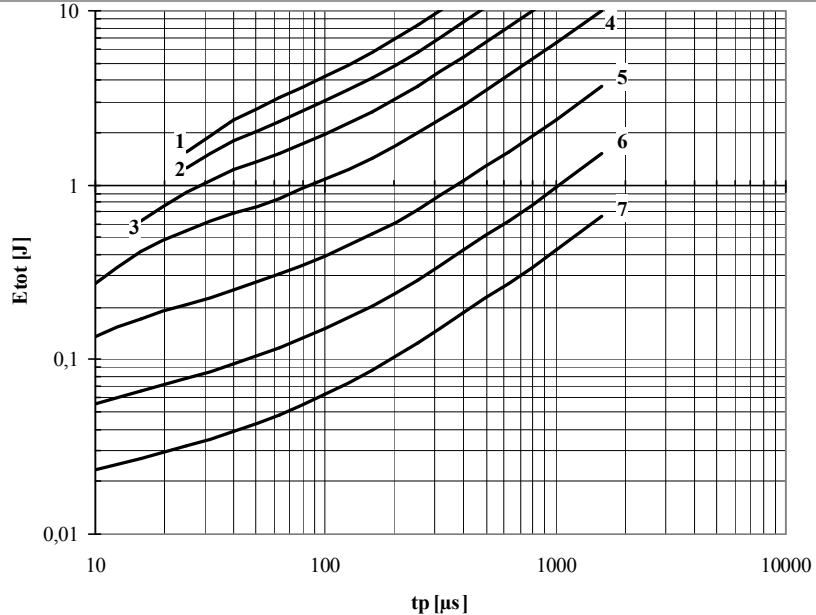


Fig. 25 Square wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $di_F/dt = di_R/dt = 500$ A/ μ s

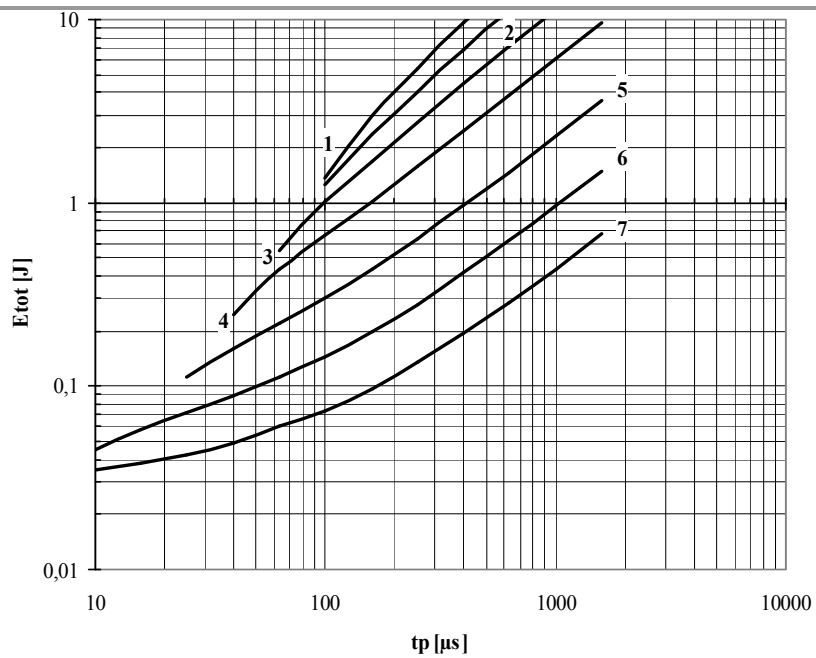


Fig. 26 Square wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $di_F/dt = di_R/dt = 100$ A/ μ s

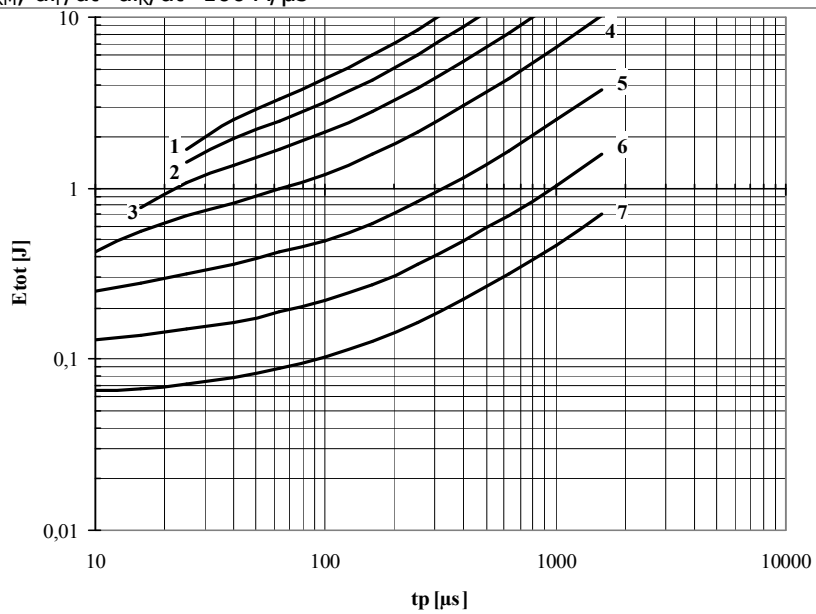


Fig. 27 Square wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $di_F/dt = di_R/dt = 500$ A/ μ s

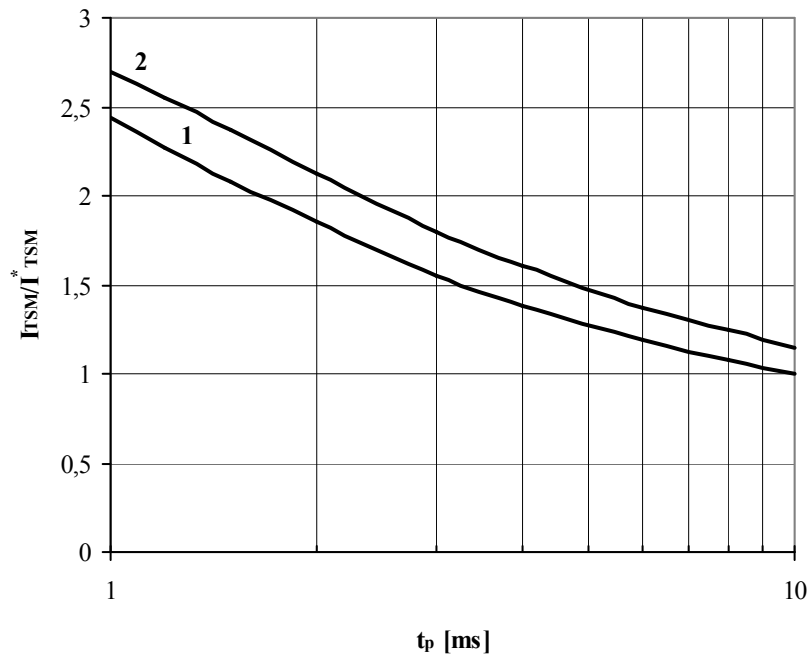


Fig. 28 The surge current I_{TSM} vs. Duration of surge t_p for a half-sine wave
 1 – $T_j=125\text{ °C}$
 2 – $T_j=25\text{ °C}$

Conditions: $V_R=0\text{ V}$ – the peak value of reverse voltage which is applied immediately after the surge current
 Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j=T_{j\text{ max}}$)

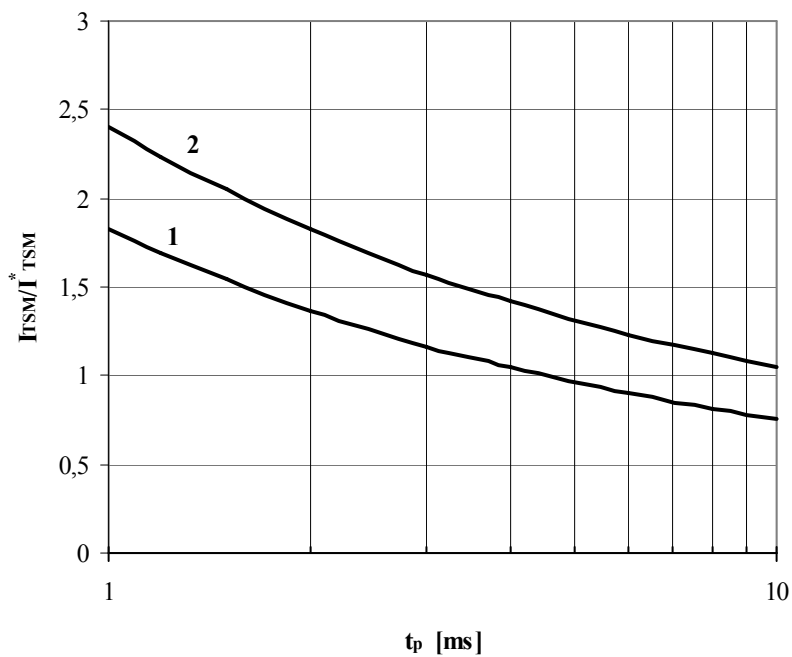


Fig. 29 The surge current I_{TSM} vs. Duration of surge t_p for a half-sine wave
 1 – $T_j=125\text{ °C}$
 2 – $T_j=25\text{ °C}$

Conditions: $V_R=0.8V_{RRM}$ – the peak value of reverse voltage which is applied immediately after the surge current
 Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j=T_{j\text{ max}}$)

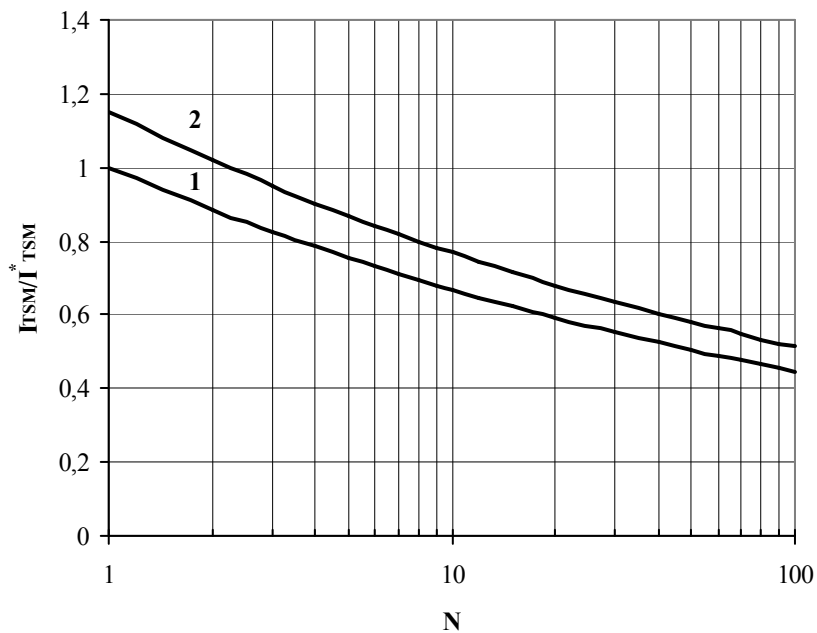


Fig. 30 The surge current I_{TSM} vs. Number of half-sine waves at 50 Hz

1 – $T_j = 125^\circ\text{C}$

2 – $T_j = 25^\circ\text{C}$

Conditions: $V_R = 0\text{ V}$ – the peak value of reverse voltage which is applied immediately after the surge current
 Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j = T_{j\text{max}}$)

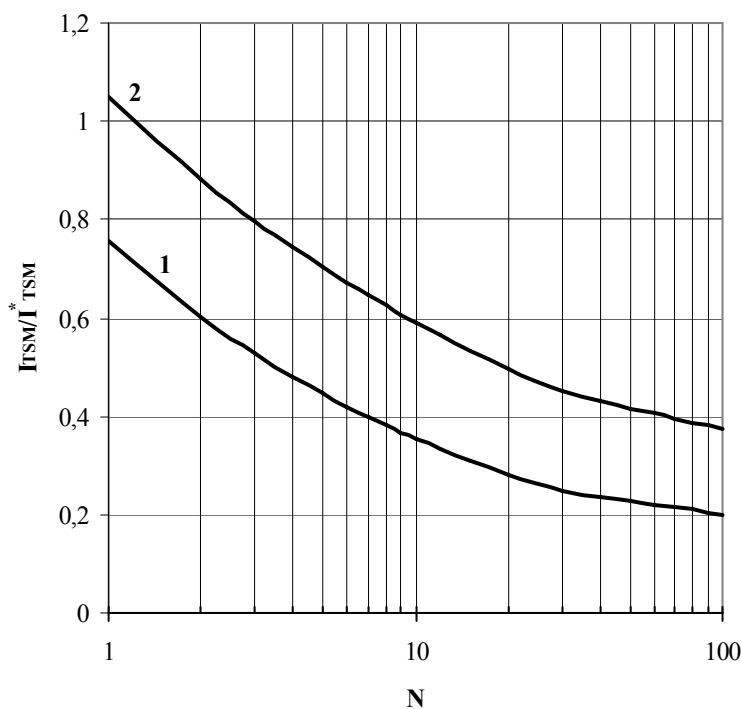


Fig. 31 The surge current I_{TSM} vs. Number of half-sine waves at 50 Hz

1 – $T_j = 125^\circ\text{C}$

2 – $T_j = 25^\circ\text{C}$

Conditions: $V_R = 0.8 \cdot V_{RRM}$ – the peak value of reverse voltage which is applied immediately after the surge current
 Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j = T_{j\text{max}}$)